

MC74AC175, MC74ACT175

Quad D Flip-Flop With Master Reset

The MC74AC/ACT175 is a high-speed quad D flip-flop. The device is useful for general flip-flop requirements where clock and clear inputs are common. The information on the D inputs is transferred to storage during the LOW-to-HIGH clock transition. The device has a Master Reset to simultaneously clear all flip-flops, when MR is low.

The MC74AC/ACT175 consists of four edge-triggered D flip-flops with individual D inputs and Q and \bar{Q} outputs. The Clock (CP) and Master Reset (MR) are common to all flip-flops. Each D input's state is transferred to the corresponding flip-flop's output following the LOW-to-HIGH Clock (CP) transition. A LOW input to the Master Reset (MR) will force all Q outputs LOW and \bar{Q} outputs HIGH independent of Clock or Data inputs. The MC74AC/ACT175 is useful for applications where the Clock and Master Reset are common to all storage elements.

- Outputs Source/Sink 24 mA
- 'ACT175 Has TTL Compatible Inputs

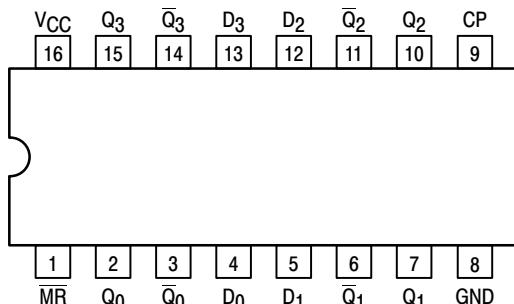


Figure 1. Pinout: 16-Lead Packages
(Top View)

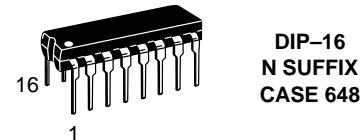
PIN ASSIGNMENT

PIN	FUNCTION
D ₀ – D ₃	Data Inputs
CP	Clock Pulse Input
MR	Master Reset Input
Q ₀ – Q ₃	Outputs
\bar{Q}_0 – \bar{Q}_3	Outputs

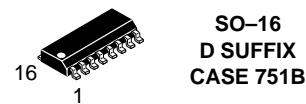


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DIP-16
N SUFFIX
CASE 648



SO-16
D SUFFIX
CASE 751B



TSSOP-16
DT SUFFIX
CASE 948F



EIAJ-16
M SUFFIX
CASE 966

ORDERING INFORMATION

Device	Package	Shipping
MC74AC175N	PDIP-16	25 Units/Rail
MC74ACT175N	PDIP-16	25 Units/Rail
MC74AC175D	SOIC-16	48 Units/Rail
MC74ACT175D	SOIC-16	48 Units/Rail
MC74AC175DR2	SOIC-16	2500 Tape & Reel
MC74ACT175DR2	SOIC-16	2500 Tape & Reel
MC74AC175DT	TSSOP-16	96 Units/Rail
MC74ACT175DT	TSSOP-16	96 Units/Rail
MC74AC175DTR2	TSSOP-16	2500 Tape & Reel
MC74ACT175DTR2	TSSOP-16	2500 Tape & Reel
MC74AC175M	EIAJ-16	50 Units/Rail

DEVICE MARKING INFORMATION

See general marking information in the device marking section on page 176 of this data sheet.

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TRUTH TABLE

Inputs			Outputs	
MR	CP	D	Qn	\bar{Q}_n
L	X	X	L	H
H	↑	H	H	L
H	↑	L	L	H
H	L	X	Qn	\bar{Q}_n

NOTE: H = HIGH Voltage Level,
 L = LOW Voltage Level
 X = Immaterial
 ↑ = LOW-to-HIGH Transition of Clock

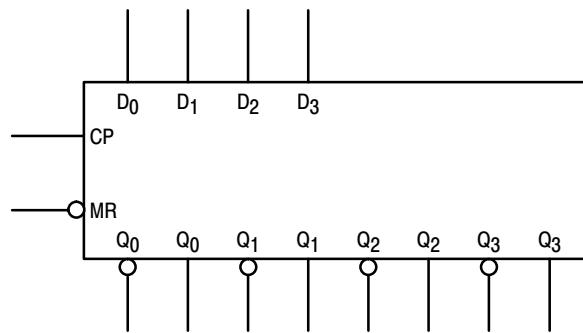
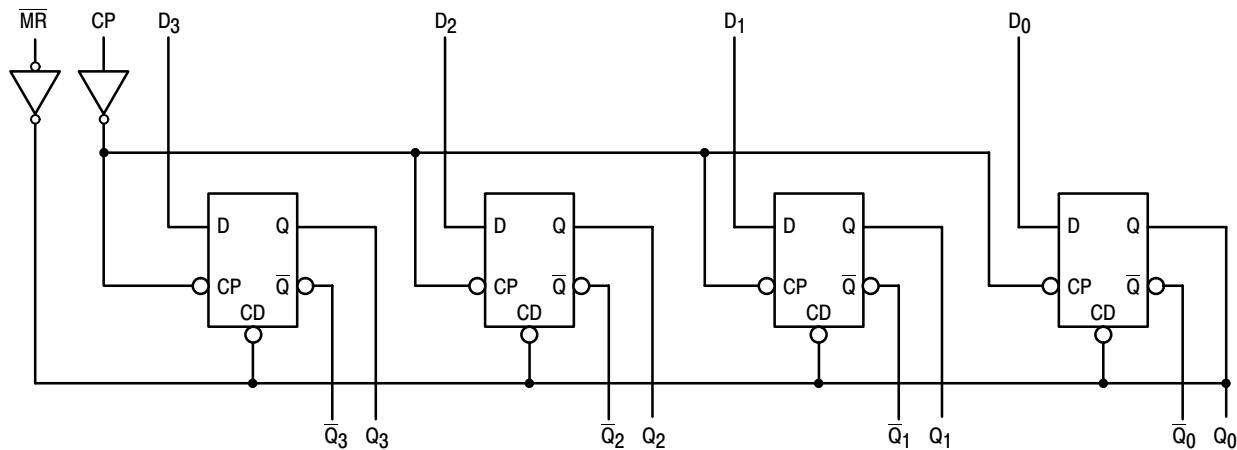


Figure 2. Logic Symbol



NOTE: This diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Figure 3. Logic Diagram

MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
V _{CC}	DC Supply Voltage (Referenced to GND)	-0.5 to +7.0	V
V _{IN}	DC Input Voltage (Referenced to GND)	-0.5 to V _{CC} + 0.5	V
V _{OUT}	DC Output Voltage (Referenced to GND)	-0.5 to V _{CC} + 0.5	V
I _{IN}	DC Input Current, per Pin	± 20	mA
I _{OUT}	DC Output Sink/Source Current, per Pin	± 50	mA
I _{CC}	DC V _{CC} or GND Current per Output Pin	± 50	mA
T _{stg}	Storage Temperature	-65 to +150	°C

*Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

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RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Min	Typ	Min	Unit
V _{CC}	Supply Voltage	'AC	2.0	5.0	6.0	V
		'ACT	4.5	5.0	5.5	
V _{in} , V _{out}	DC Input Voltage, Output Voltage (Ref. to GND)		0	-	V _{CC}	V
t _r , t _f	Input Rise and Fall Time (Note 1) 'AC Devices except Schmitt Inputs	V _{CC} @ 3.0 V	-	150	-	ns/V
		V _{CC} @ 4.5 V	-	40	-	
		V _{CC} @ 5.5 V	-	25	-	
t _r , t _f	Input Rise and Fall Time (Note 2) 'ACT Devices except Schmitt Inputs	V _{CC} @ 4.5 V	-	10	-	ns/V
		V _{CC} @ 5.5 V	-	8.0	-	
T _J	Junction Temperature (PDIP)		-	-	140	°C
T _A	Operating Ambient Temperature Range		-40	25	85	°C
I _{OH}	Output Current – HIGH		-	-	-24	mA
I _{OL}	Output Current – LOW		-	-	24	mA

1. V_{IN} from 30% to 70% V_{CC}; see individual Data Sheets for devices that differ from the typical input rise and fall times.
 2. V_{IN} from 0.8 V to 2.0 V; see individual Data Sheets for devices that differ from the typical input rise and fall times.

DC CHARACTERISTICS

Symbol	Parameter	V _{CC} (V)	74AC		Unit	Conditions		
			T _A = +25°C					
			Typ	Guaranteed Limits				
V _{IH}	Minimum High Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	2.1 3.15 3.85	2.1 3.15 3.85	V V _{OUT} = 0.1 V or V _{CC} – 0.1 V		
V _{IL}	Maximum Low Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	0.9 1.35 1.65	0.9 1.35 1.65	V V _{OUT} = 0.1 V or V _{CC} – 0.1 V		
V _{OH}	Minimum High Level Output Voltage	3.0 4.5 5.5	2.99 4.49 5.49	2.9 4.4 5.4	2.9 4.4 5.4	V I _{OUT} = -50 μA		
		3.0 4.5 5.5	- - -	2.56 3.86 4.86	2.46 3.76 4.76	V *V _{IN} = V _{IL} or V _{IH} I _{OH} = 12 mA I _{OH} = 24 mA		
V _{OL}	Maximum Low Level Output Voltage	3.0 4.5 5.5	0.002 0.001 0.001	0.1 0.1 0.1	0.1 0.1 0.1	V I _{OUT} = 50 μA		
		3.0 4.5 5.5	- - -	0.36 0.36 0.36	0.44 0.44 0.44	V *V _{IN} = V _{IL} or V _{IH} I _{OH} = 12 mA I _{OH} = 24 mA		
I _{IN}	Maximum Input Leakage Current	5.5	-	±0.1	±1.0	μA V _I = V _{CC} , GND		
I _{OLD}	†Minimum Dynamic Output Current	5.5	-	-	75	mA V _{OLD} = 1.65 V Max		
I _{OHD}		5.5	-	-	-75	mA V _{OHD} = 3.85 V Min		

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

NOTE: I_{IN} and I_{CC} @ 3.0 V are guaranteed to be less than or equal to the respective limit @ 5.5 V V_{CC}.

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DC CHARACTERISTICS (continued)

Symbol	Parameter	V _{CC} (V)	74AC		74AC		Unit	Conditions		
			T _A = +25°C		T _A = -40°C to +85°C					
			Typ	Guaranteed Limits						
I _{CC}	Maximum Quiescent Supply Current	5.5	—	8.0	80	—	μA	V _{IN} = V _{CC} or GND		

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

NOTE: I_{IN} and I_{CC} @ 3.0 V are guaranteed to be less than or equal to the respective limit @ 5.5 V V_{CC}.

AC CHARACTERISTICS

Symbol	Parameter	V _{CC} * (V)	74AC			74AC		Unit	Fig. No.		
			T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF					
			Min	Typ	Max	Min	Max				
f _{max}	Maximum Clock Frequency	3.3 5.0	149 187	— —	— —	139 187	— —	MHz	3-3		
t _{PLH}	Propagation Delay CP to Q _n or \bar{Q}_n	3.3 5.0	2.0 1.5	— —	12.0 9.0	2.0 1.0	13.5 9.5	ns	3-6		
t _{PHL}	Propagation Delay CP to \bar{Q}_n or Q _n	3.3 5.0	2.5 1.5	— —	13.0 9.5	2.0 1.5	14.5 10.5	ns	3-6		
t _{PLH}	Propagation Delay MR to \bar{Q}_n	3.3 5.0	3.0 2.0	— —	12.5 9.0	2.5 1.5	13.5 10.0	ns	3-6		
t _{PHL}	Propagation Delay MR to Q _n	3.3 5.0	3.0 2.0	— —	11.0 8.5	2.5 1.5	12.5 9.0	ns	3-6		

AC OPERATING REQUIREMENTS

Symbol	Parameter	V _{CC} * (V)	74AC		74AC		Unit	Fig. No.		
			T _A = +25°C C _L = 50 pF		T _A = -40°C to +85°C C _L = 50 pF					
			Typ	Guaranteed Minimum						
t _s	Set-up Time, HIGH or LOW D _n to CP	3.3 5.0	— —	4.5 3.0	— —	4.5 3.0	ns	3-9		
t _h	Hold Time, HIGH or LOW D _n to CP	3.3 5.0	— —	1.0 1.0	— —	1.0 1.0	ns	3-9		
t _w	MR Pulse Width Low	3.3 5.0	— —	4.5 3.5	— —	4.5 3.5	ns	3-6		
t _w	CP Pulse Width	3.3 5.0	— —	4.5 3.5	— —	5.0 3.5	ns	3-6		
t _{rec}	Recovery Time MR to CP	3.3 5.0	— —	0 0	— —	0 0	ns	3-6		

*Voltage Range 3.3 V is 3.3 V \pm 0.3 V.

*Voltage Range 5.0 V is 5.0 V \pm 0.5 V.

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DC CHARACTERISTICS

Symbol	Parameter	V_{CC} (V)	74ACT		74ACT		Unit	Conditions		
			$T_A = +25^\circ C$		$T_A = -40^\circ C \text{ to } +85^\circ C$					
			Typ	Guaranteed Limits						
V_{IH}	Minimum High Level Input Voltage	4.5 5.5	1.5 1.5	2.0 2.0	2.0 2.0	2.0 2.0	V	$V_{OUT} = 0.1 V$ $\text{or } V_{CC} - 0.1 V$		
V_{IL}	Maximum Low Level Input Voltage	4.5 5.5	1.5 1.5	0.8 0.8	0.8 0.8	0.8 0.8	V	$V_{OUT} = 0.1 V$ $\text{or } V_{CC} - 0.1 V$		
V_{OH}	Minimum High Level Output Voltage	4.5 5.5	4.49 5.49	4.4 5.4	4.4 5.4	4.4 5.4	V	$I_{OUT} = -50 \mu A$		
		4.5 5.5	— —	3.86 4.86	3.76 4.76	3.76 4.76	V	$*V_{IN} = V_{IL} \text{ or } V_{IH}$ $- 24 mA$ $I_{OH} \quad - 24 mA$		
V_{OL}	Maximum Low Level Output Voltage	4.5 5.5	0.001 0.001	0.1 0.1	0.1 0.1	0.1 0.1	V	$I_{OUT} = 50 \mu A$		
		4.5 5.5	— —	0.36 0.36	0.44 0.44	0.44 0.44	V	$*V_{IN} = V_{IL} \text{ or } V_{IH}$ $24 mA$ $I_{OH} \quad 24 mA$		
I_{IN}	Maximum Input Leakage Current	5.5	—	± 0.1	± 1.0		μA	$V_I = V_{CC}, GND$		
ΔI_{CCT}	Additional Max. I_{CC} /Input	5.5	0.6	—	1.5		mA	$V_I = V_{CC} - 2.1 V$		
I_{OLD}	†Minimum Dynamic Output Current	5.5	—	—	75		mA	$V_{OLD} = 1.65 V$ Max		
I_{OHD}		5.5	—	—	-75		mA	$V_{OHD} = 3.85 V$ Min		
I_{CC}	Maximum Quiescent Supply Current	5.5	—	8.0	80		μA	$V_{IN} = V_{CC}$ or GND		

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

AC CHARACTERISTICS

Symbol	Parameter	V_{CC}^* (V)	74ACT			74ACT		Unit	Fig. No.		
			$T_A = +25^\circ C$ $C_L = 50 pF$			$T_A = -40^\circ C$ $\text{to } +85^\circ C$ $C_L = 50 pF$					
			Min	Typ	Max	Min	Max				
f_{max}	Maximum Clock Frequency	5.0	175	—	—	145	—	MHz	3-3		
t_{PLH}	Propagation Delay CP to Q_n	5.0	2.0	—	10.0	1.5	11.0	ns	3-6		
t_{PHL}	Propagation Delay CP to \bar{Q}_n	5.0	2.0	—	11.0	1.5	12.0	ns	3-6		
t_{PHL}	Propagation Delay MR to Q_n or \bar{Q}_n	5.0	2.0	—	9.5	1.5	10.5	ns	3-6		

*Voltage Range 5.0 V is $5.0 V \pm 0.5 V$.

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AC OPERATING REQUIREMENTS

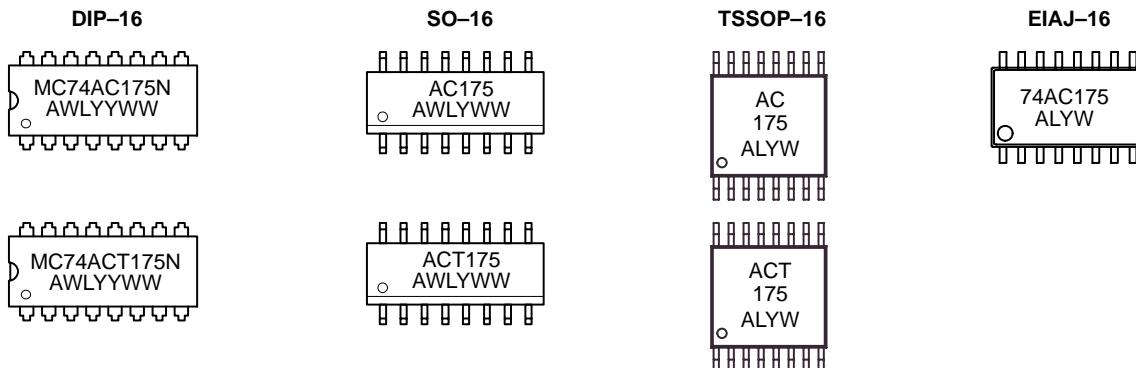
Symbol	Parameter	V_{CC}^* (V)	74ACT		Unit	Fig. No.		
			$T_A = +25^\circ C$ $C_L = 50 \text{ pF}$					
			Typ	Guaranteed Minimum				
t_S (H) (L)	Set-up Time, HIGH or LOW D_N to CP	5.0	—	2.0 2.5	2.0 2.5	ns 3-9		
t_h	Hold Time, HIGH or LOW D_N to CP	5.0	—	1.0	1.0	ns 3-9		
t_w	MR Pulse Width, LOW	5.0	—	3.0	4.0	ns 3-6		
t_w	CP Pulse Width, HIGH or LOW	5.0	—	3.0	3.5	ns 3-6		
t_{rec}	Recovery Time MR to CP	5.0	—	0	0	ns 3-6		

*Voltage Range 5.0 V is 5.0 V ± 0.5 V.

CAPACITANCE

Symbol	Parameter	Value Typ	Unit	Test Conditions
C_{IN}	Input Capacitance	4.5	pF	$V_{CC} = 5.0$ V
C_{PD}	Power Dissipation Capacitance	45.0	pF	$V_{CC} = 5.0$ V

MARKING DIAGRAMS



A = Assembly Location

WL, L = Wafer Lot

YY, Y = Year

WW, W = Work Week